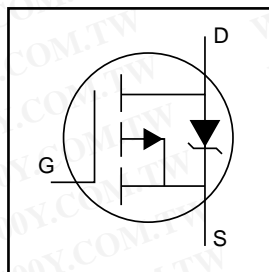


- P-Channel
- Surface Mount (IRFR9310)
- Straight Lead (IRFU9310)
- Advanced Process Technology
- Fast Switching
- Fully Avalanche Rated



$$V_{DSS} = -400V$$

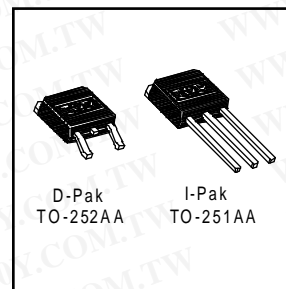
$$R_{DS(on)} = 7.0\Omega$$

$$I_D = -1.8A$$

Description

Third Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D-Pak is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.



D-Pak
TO-252AA

I-Pak
TO-251AA

Absolute Maximum Ratings

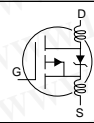
	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$	-1.8	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$	-1.1	
I_{DM}	Pulsed Drain Current ①	-7.2	
$P_D @ T_C = 25^\circ C$	Power Dissipation	50	W
	Linear Derating Factor	0.40	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy②	92	mJ
I_{AR}	Avalanche Current①	-1.8	A
E_{AR}	Repetitive Avalanche Energy①	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-24	V/ns
T_J	Operating Junction and	-55 to + 150	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds		

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	2.5	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)**	—	50	
$R_{\theta JA}$	Junction-to-Ambient	—	110	

IRFR/U9310

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-400	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.41	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	7.0	Ω	$V_{GS} = -10V, I_D = -1.1A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
g_{fs}	Forward Transconductance	0.91	—	—	S	$V_{DS} = -50V, I_D = -1.1A$
I_{DSS}	Drain-to-Source Leakage Current	—	—	-100	μA	$V_{DS} = -400V, V_{GS} = 0V$
		—	—	-500		$V_{DS} = -320V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
Q_g	Total Gate Charge	—	—	13	nC	$I_D = -1.1A$
Q_{gs}	Gate-to-Source Charge	—	—	3.2		$V_{DS} = -320V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	5.0		$V_{GS} = -10V$, See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	11	—	ns	$V_{DD} = -200V$
t_r	Rise Time	—	10	—		$I_D = -1.1A$
$t_{d(off)}$	Turn-Off Delay Time	—	25	—		$R_G = 21\Omega$
t_f	Fall Time	—	24	—		$R_D = 180\Omega$, See Fig. 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact ⑤
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	270	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	50	—		$V_{DS} = -25V$
C_{rss}	Reverse Transfer Capacitance	—	8.0	—		$f = 1.0\text{MHz}$, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-1.8	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-7.2		
V_{SD}	Diode Forward Voltage	—	—	-4.0	V	$T_J = 25^\circ\text{C}, I_S = -1.1A, V_{GS} = 0V$ ④
t_{rr}	Reverse Recovery Time	—	170	260	ns	$T_J = 25^\circ\text{C}, I_F = -1.1A$
Q_{rr}	Reverse Recovery Charge	—	640	960	nC	$di/dt = 100A/\mu s$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
 ② Starting $T_J = 25^\circ\text{C}$, $L = 57\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = -1.8A$. (See Figure 12)
 ③ $I_{SD} \leq -1.1A$, $di/dt \leq 450A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$,
 $T_J \leq 150^\circ\text{C}$

④ Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.

⑤ This is applied for I-PAK, L_S of D-PAK is measured between lead and center of die contact

** When mounted on 1" square PCB (FR-4 or G-10 Material) .
 For recommended footprint and soldering techniques refer to application note #AN-994

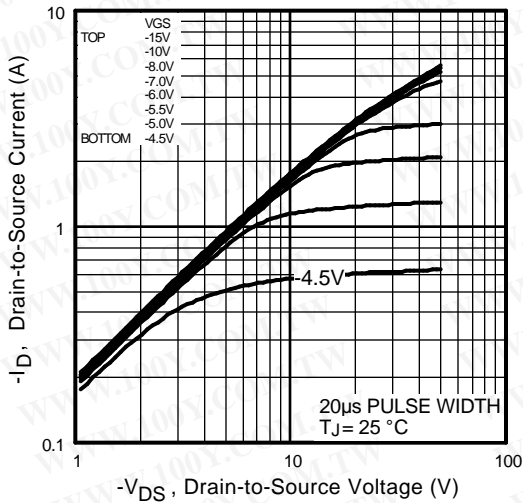


Fig 1. Typical Output Characteristics

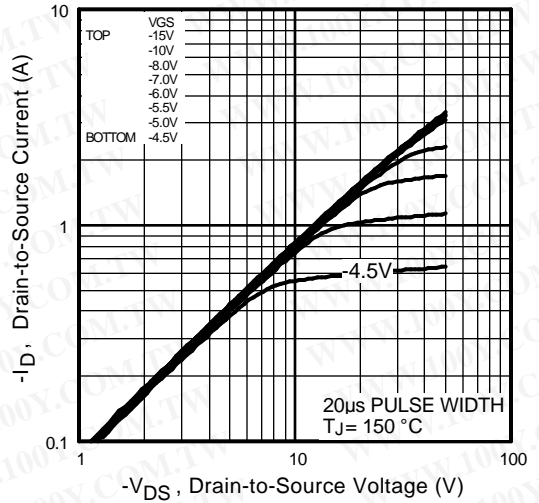


Fig 2. Typical Output Characteristics

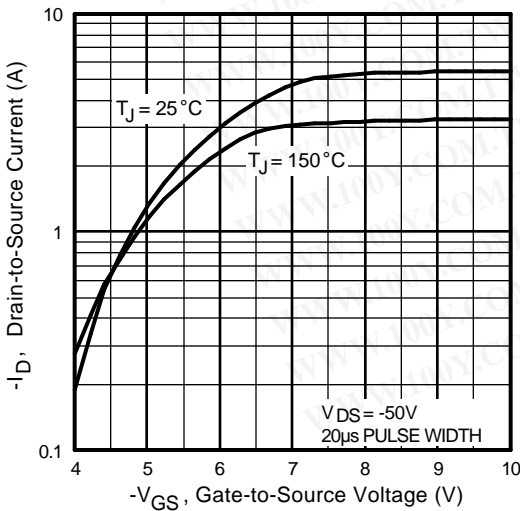


Fig 3. Typical Transfer Characteristics

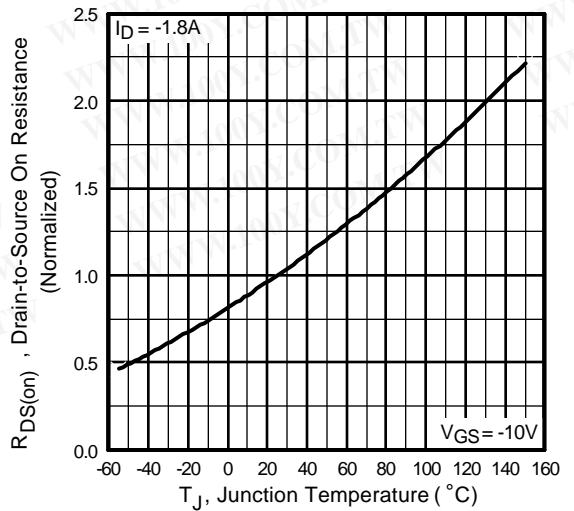


Fig 4. Normalized On-Resistance Vs. Temperature

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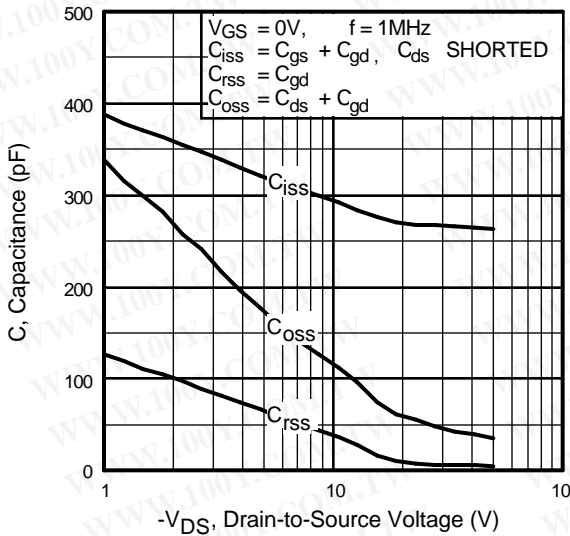


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

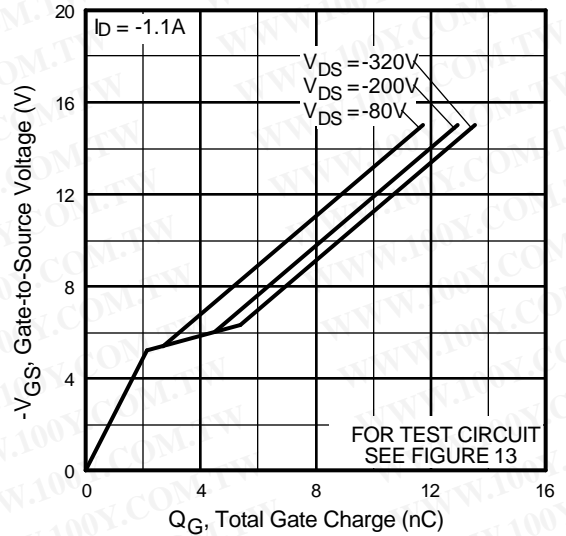


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

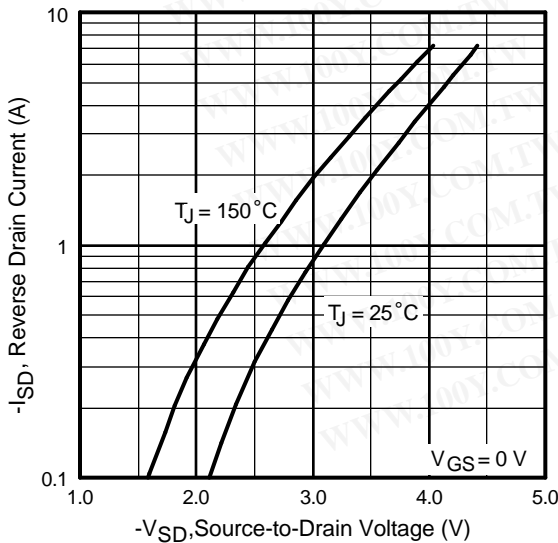


Fig 7. Typical Source-Drain Diode Forward Voltage

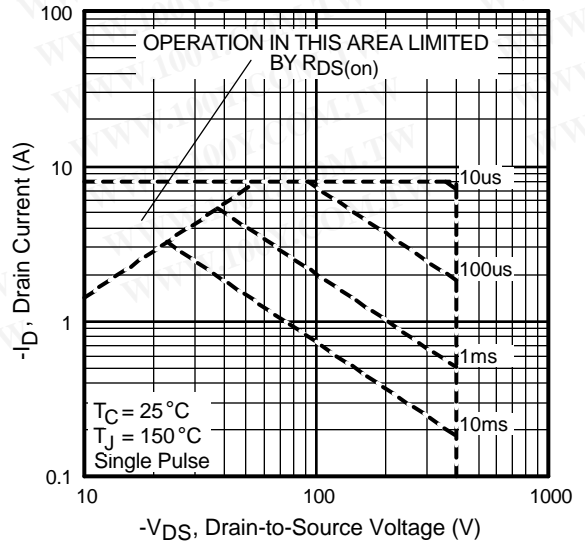


Fig 8. Maximum Safe Operating Area

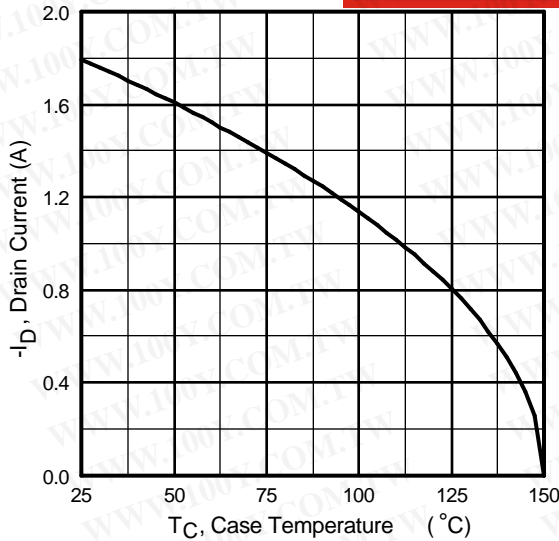


Fig 9. Maximum Drain Current Vs. Case Temperature

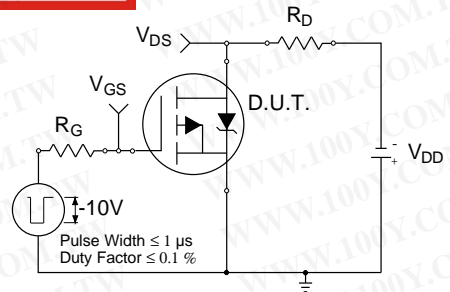


Fig 10a. Switching Time Test Circuit

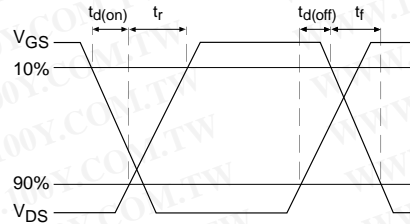


Fig 10b. Switching Time Waveforms

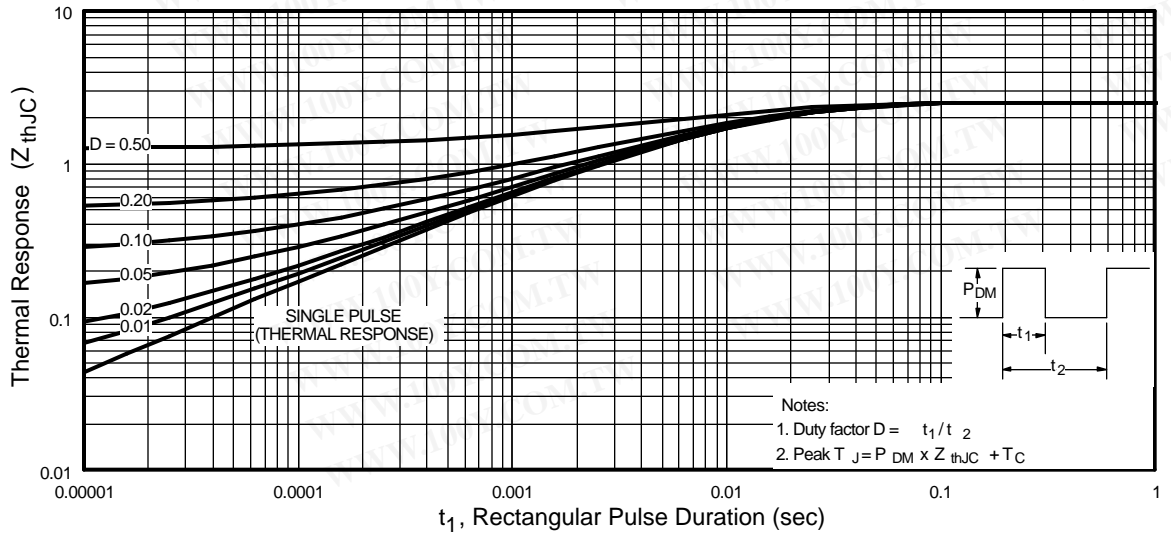


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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International
IR Rectifier

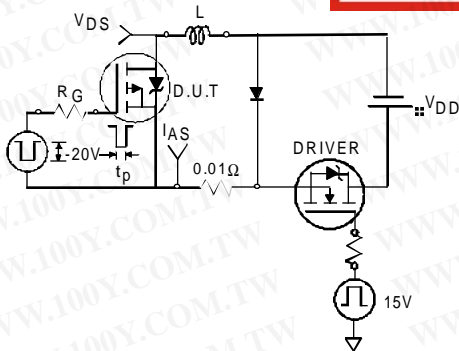


Fig 12a. Unclamped Inductive Test Circuit

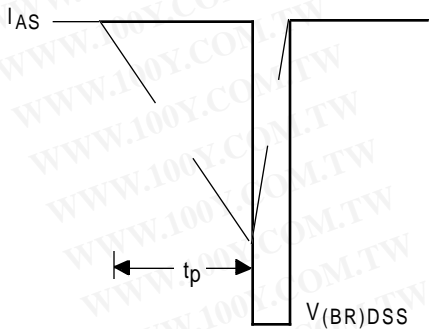


Fig 12b. Unclamped Inductive Waveforms

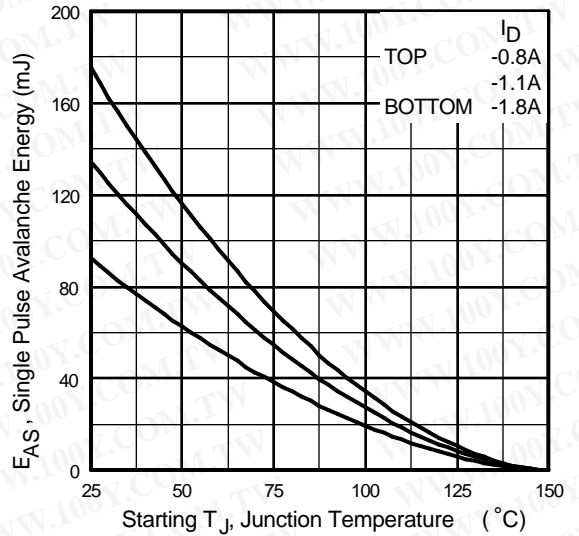


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

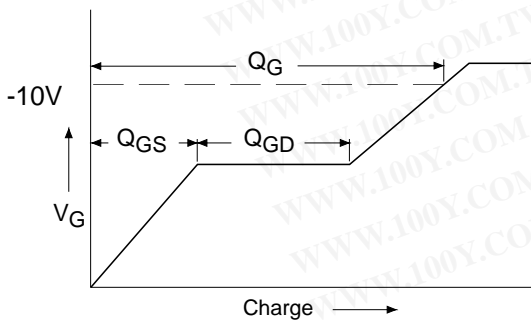


Fig 13a. Basic Gate Charge Waveform

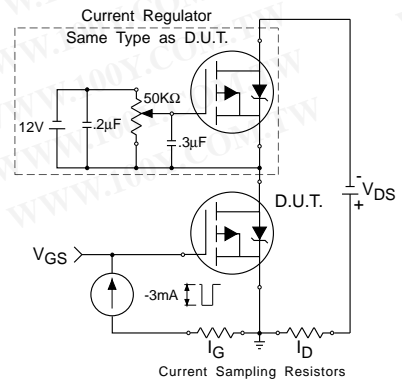
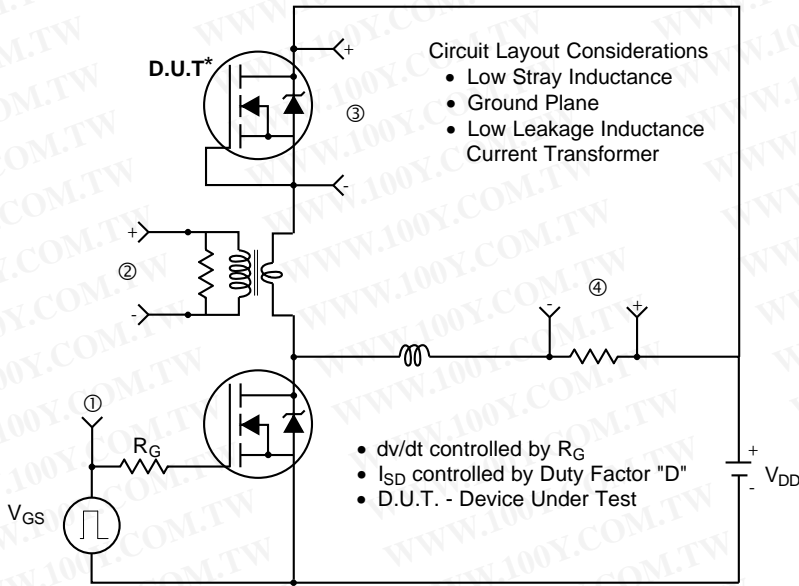
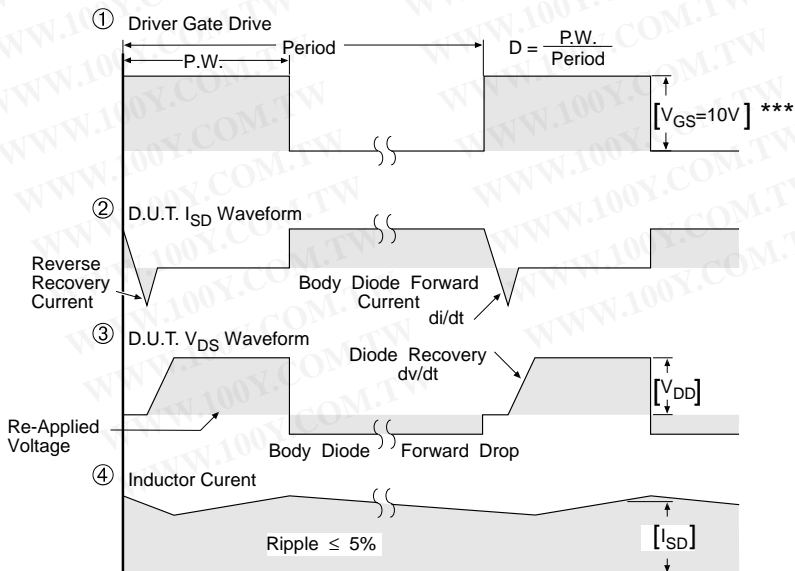


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity of D.U.T for P-Channel



*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

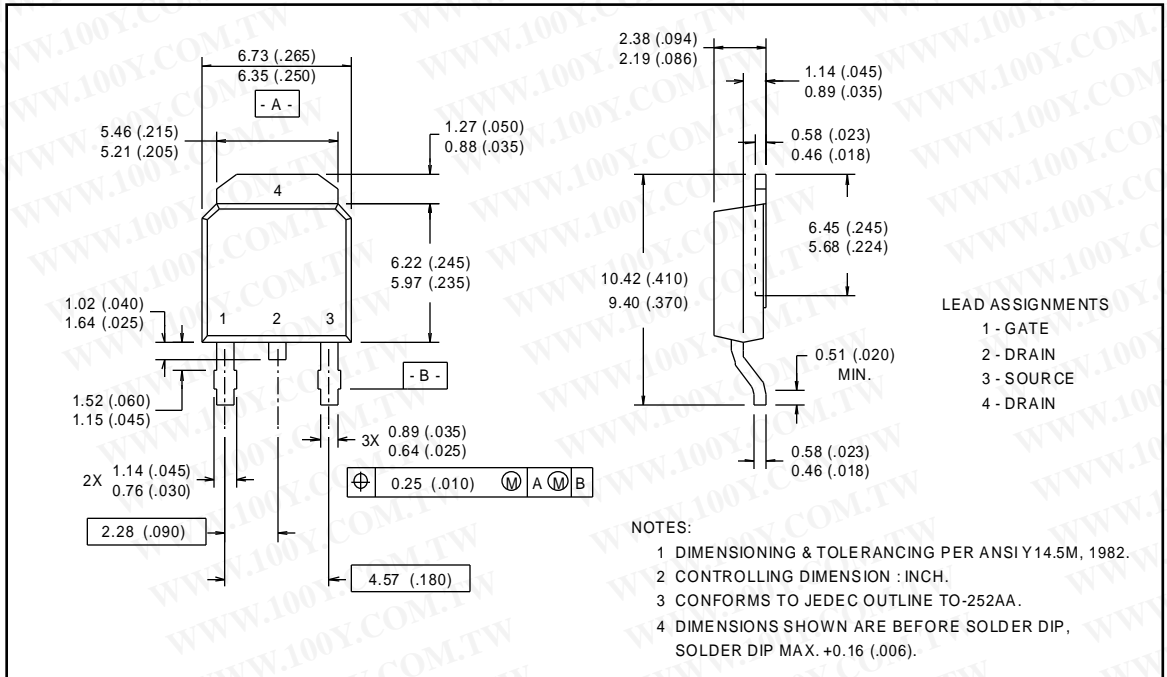
Fig 14. For P-Channel HEXFETS

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Package Outline

TO-252AA Outline

Dimensions are shown in millimeters (inches)



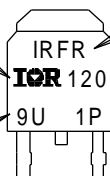
Part Marking Information

TO-252AA (D-Pak)

EXAMPLE : THIS IS AN IRFR120
 WITH ASSEMBLY
 LOT CODE 9U1P

INTERNATIONAL
 RECTIFIER
 LOGO

ASSEMBLY
 LOT CODE



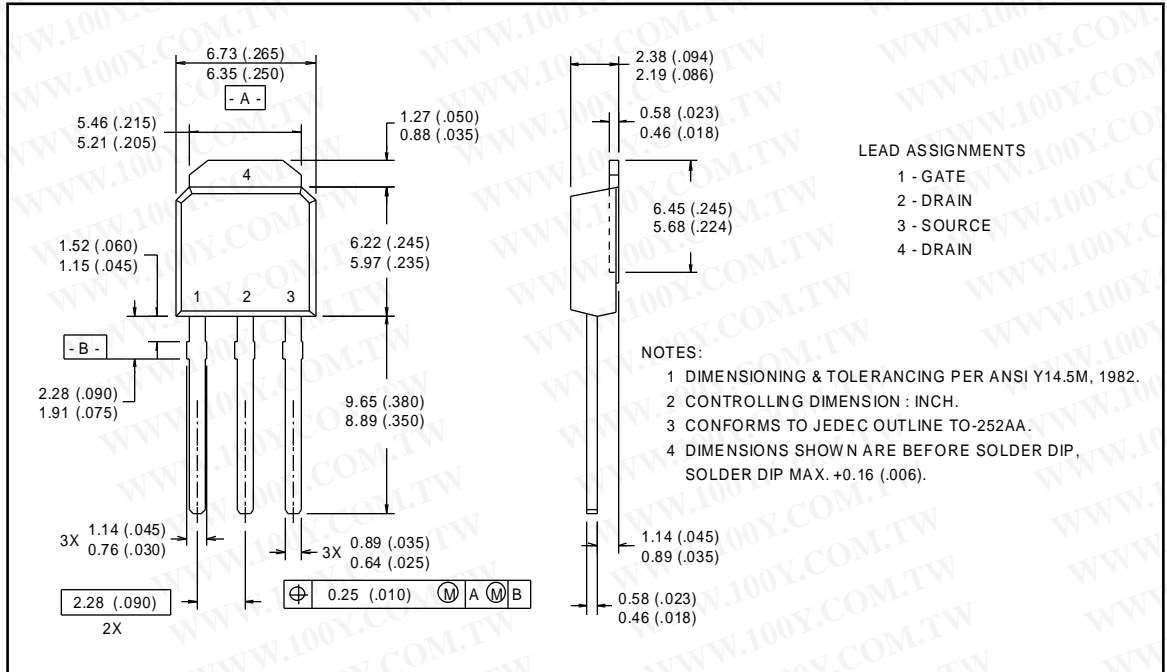
FIRST PORTION
 OF PART NUMBER

SECOND PORTION
 OF PART NUMBER

Package Outline

TO-251AA Outline

Dimensions are shown in millimeters (inches)



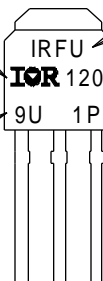
Part Marking Information

TO-251AA (I-Pak)

EXAMPLE : THIS IS AN IRFU120
 WITH ASSEMBLY
 LOT CODE 9U1P

INTERNATIONAL
 RECTIFIER
 LOGO

ASSEMBLY
 LOT CODE



FIRST PORTION
 OF PART NUMBER

SECOND PORTION
 OF PART NUMBER

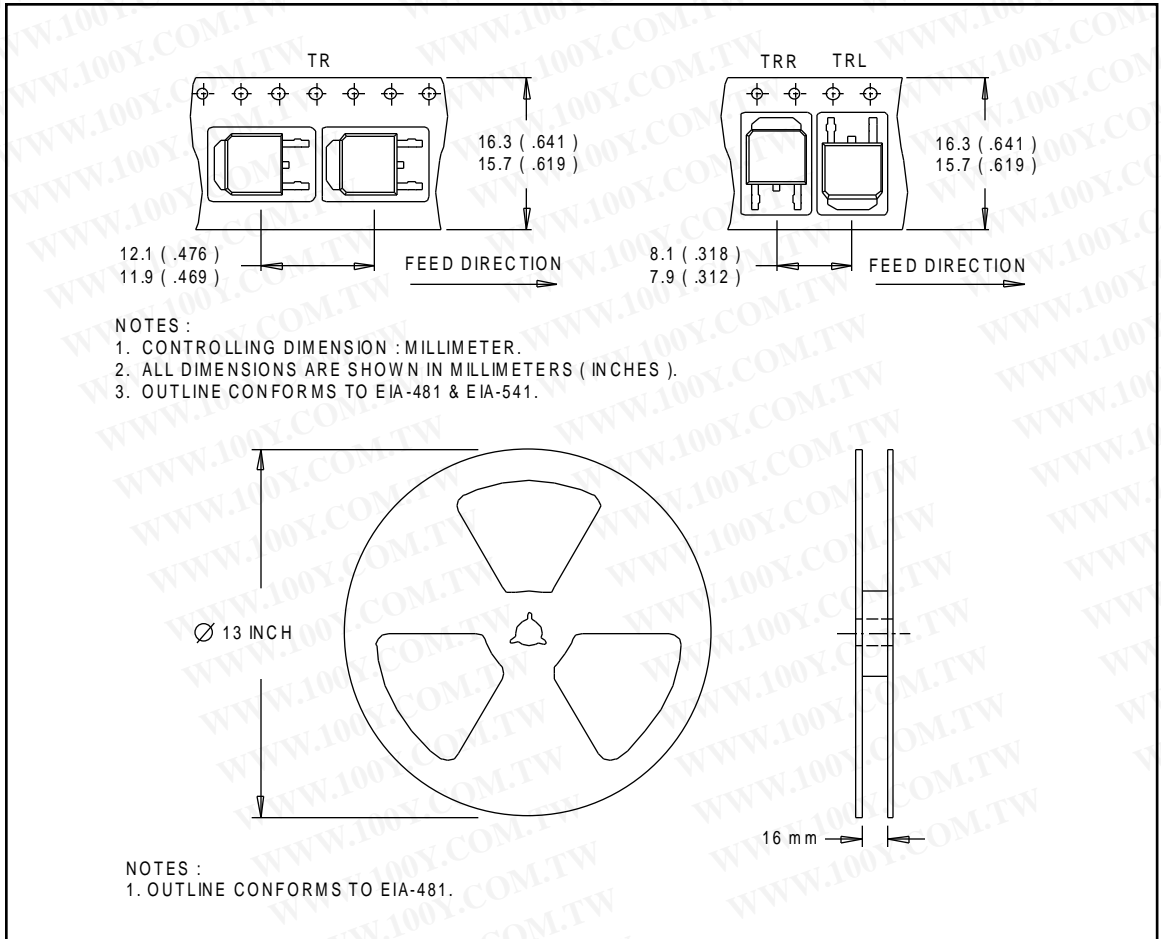
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